## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination WU ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,104,454	08-2000	Hiyama et al.	349/65
*	В	US-6,257,726	07-2001	Okuyama, Atsushi	353/20
	С	US-			
	D	US-			
	E	US-			
	F	US-			·
	G	US-			
	н	US-			
	Ι	US-			
	J	US-			
	κ	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
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## **NON-PATENT DOCUMENTS**

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	<b>v</b>							
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.